

Notice of References Cited	Application/Control No. 10/329,680	Applicant(s)/Patent Under Reexamination KWON, HO YUP	
	Examiner Long K. Tran	Art Unit 2818	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
4P	*	A US-6,528,854	03-2003	Yoshida et al.	257/395
4P	*	B US-6,017,823	01-2000	Shishiguchi et al.	438/696
		C US-			
		D US-			
		E US-			
		F US-			
		G US-			
		H US-			
		I US-			
		J US-			
		K US-			
		L US-			
		M US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
		N				
		O				
		P				
		Q				
		R				
		S				
		T				

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.